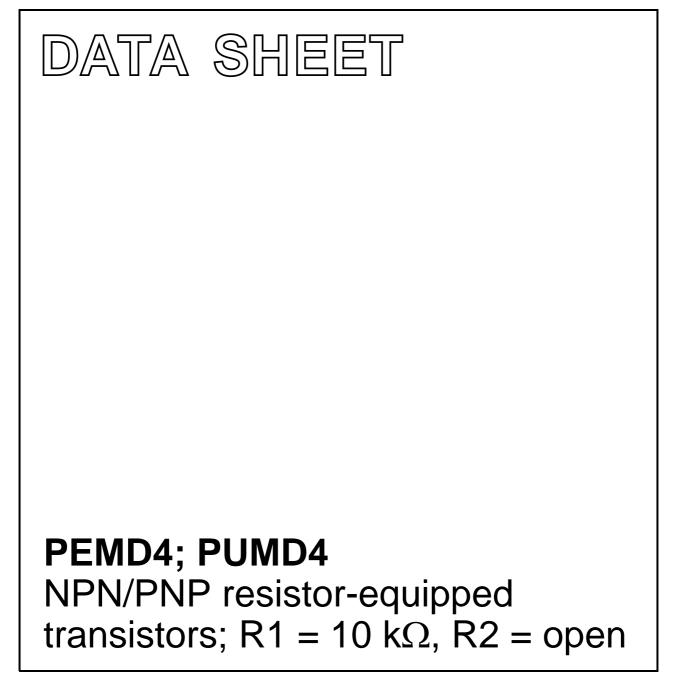
DISCRETE SEMICONDUCTORS



Product data sheet Supersedes data of 2002 Jan 14 2003 Oct 10



### PEMD4; PUMD4

#### FEATURES

- · Built-in bias resistors
- Simplified circuit design
- Reduction of component count
- Reduced pick and place costs.

#### APPLICATIONS

- Low current peripheral driver
- Replacement for general purpose transistors in digital applications
- Control of IC inputs.

### QUICK REFERENCE DATA

SYMBOL	PARAMETER	TYP.	MAX.	UNIT
V <sub>CEO</sub>	collector-emitter voltage	-	50	V
lo	output current (DC)	-	100	mA
TR1	NPN	_	_	-
TR2	PNP	_	-	-
R1	bias resistor	10	-	kΩ
R2	open	_	_	_

### DESCRIPTION

NPN/PNP resistor-equipped transistors (see "Simplified outline, symbol and pinning" for package details).

### PRODUCT OVERVIEW

TYPE	PAC	AGE	MARKING CODE PNP/PNP		NPN/NPN
NUMBER	PHILIPS	EIAJ	MARKING CODE	COMPLEMENT COMPLEM	
PEMD4	SOT666		23	PEMB4	PEMH4
PUMD4	SOT363	SC-88	D*4	PUMB4	PUMH4

#### Note

- 1. \* = p: Made in Hong Kong.
  - \* = t: Made in Malaysia.
  - \* = W: Made in China.

#### SIMPLIFIED OUTLINE, SYMBOL AND PINNING

TYPE NUMBER	SIMPLIFIED OUTLINE AND SYMBOL		PINNING		
		PIN	DESCRIPTION		
PEMD4	6 5 4	1	emitter TR1		
PUMD4		2	base TR1		
		3	collector TR2		
		4	emitter TR2		
		5	base TR2		
		6	collector TR1		
	1 2 3 Top view MDB814				
	Top view MDB814				

### Product data sheet

### PEMD4; PUMD4

#### ORDERING INFORMATION

TYPE NUMBER		PACKAGE	
ITPE NUMBER	NAME DESCRIPTION		VERSION
PEMD4	_	plastic surface mounted package; 6 leads	SOT666
PUMD4	<ul> <li>plastic surface mounted package; 6 leads</li> </ul>		SOT363

#### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Per transist	or; for the PNP transistor with ne	egative polarity	·		
V <sub>CBO</sub>	collector-base voltage	open emitter	_	50	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	50	V
V <sub>EBO</sub>	emitter-base voltage	open collector	_	5	V
I <sub>O</sub>	output current (DC)		_	100	mA
I <sub>CM</sub>	peak collector current		-	100	mA
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$			
	SOT363	note 1	-	200	mW
	SOT666	notes 1 and 2	-	200	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		_	150	°C
T <sub>amb</sub>	operating ambient temperature		-65	+150	°C
Per device	·		·		
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$			
	SOT363	note 1	-	300	mW
	SOT666	notes 1 and 2	_	300	mW

#### Notes

1. Device mounted on an FR4 printed-circuit board, single-sided copper, standard footprint.

2. Reflow soldering is the only recommended soldering method.

### PEMD4; PUMD4

#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT	
Per transi	stor	·	· · ·		
R <sub>th j-a</sub>	thermal resistance from junction to ambient	$T_{amb} \le 25 \ ^{\circ}C$			
	SOT363	note 1	625	K/W	
	SOT666	notes 1 and 2	625	K/W	
Per device	9				
R <sub>th j-a</sub>	thermal resistance from junction to ambient	$T_{amb} \le 25 \ ^{\circ}C$			
	SOT363	note 1	416	K/W	
	SOT666	notes 1 and 2	416	K/W	

#### Notes

1. Device mounted on an FR4 printed-circuit board, single-sided copper, standard footprint.

2. Reflow soldering is the only recommended soldering method.

### CHARACTERISTICS

 $T_{amb}$  = 25 °C unless otherwise specified.

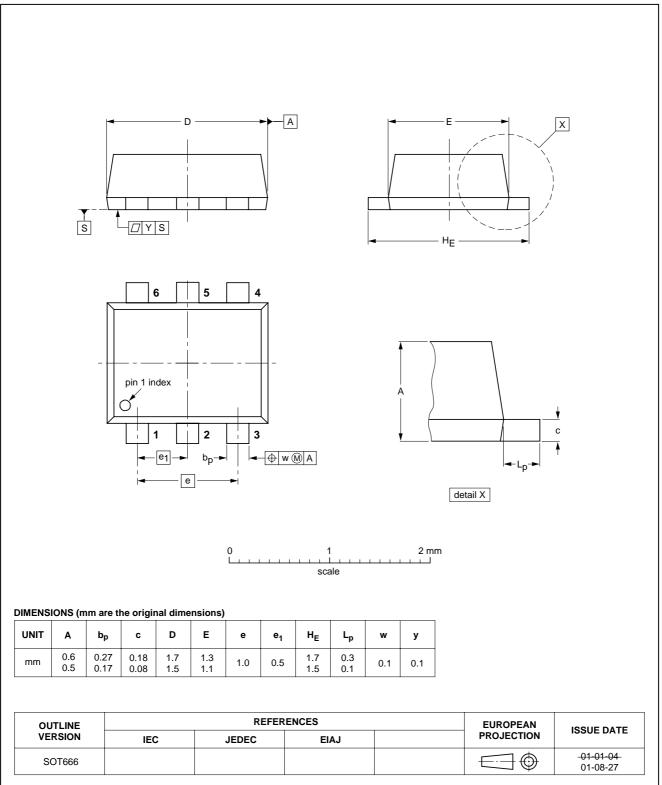
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Per transis	Per transistor; for the PNP transistor with negative polarity						
I <sub>CBO</sub>	collector-base cut-off current	$V_{CB} = 50 \text{ V}; \text{ I}_{E} = 0$	_	_	100	nA	
I <sub>CEO</sub>	collector-emitter cut-off current	$V_{CE} = 30 \text{ V}; \text{ I}_{B} = 0$	-	-	1	μA	
		$V_{CE} = 30 \text{ V}; I_B = 0; T_j = 150 ^{\circ}\text{C}$	-	-	50	μA	
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 5 V; I_{C} = 0$	-	-	100	nA	
h <sub>FE</sub>	DC current gain	$V_{CE} = 5 \text{ V}; \text{ I}_{C} = 1 \text{ mA}$	200	-	-		
V <sub>CEsat</sub>	collector-emitter saturation voltage	$I_{C} = 10 \text{ mA}; I_{B} = 0.5 \text{ mA}$	-	-	150	mV	
R1	input resistor		7	10	13	kΩ	
C <sub>c</sub>	collector capacitance	I <sub>E</sub> = i <sub>e</sub> = 0; V <sub>CB</sub> = 10 V; f = 1 MHz					
	TR1 (NPN)		-	-	2.5	pF	
	TR2 (PNP)		-	-	3	pF	

PEMD4; PUMD4

## NPN/PNP resistor-equipped transistors; R1 = 10 k $\Omega$ , R2 = open

### PACKAGE OUTLINES

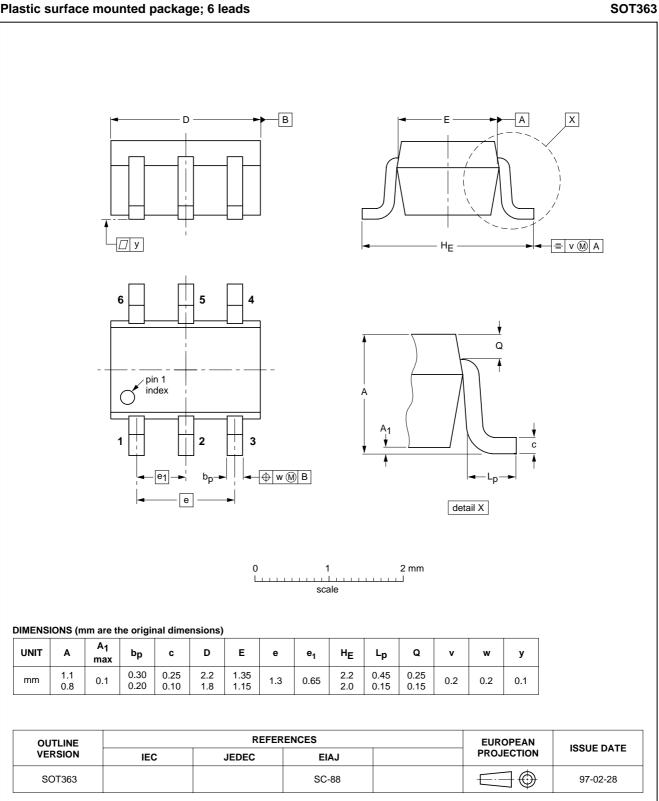
### Plastic surface mounted package; 6 leads



**SOT666** 

## NPN/PNP resistor-equipped transistors; $R1 = 10 \text{ k}\Omega$ , R2 = open

### PEMD4; PUMD4



### PEMD4; PUMD4

#### DATA SHEET STATUS

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

#### Notes

- 1. Please consult the most recently issued document before initiating or completing a design.
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# **NXP Semiconductors**

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#### **Contact information**

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